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Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/543,136	TANIKAWA, AKIO	
Examiner	Art Unit	
Caridad M. Everhart	2891	

SEARCHED				
Class	Subclass	Date	Examiner	
257	2	9/29/2007	СМЕ	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST(attached)		9/29/2007	СМЕ
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